



IFW
PATENT
8075-1024

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Kuniyoshi YOKOH et al.

Application No. 10/562,835

Filed December 29, 2005

ELECTRON-EMITTING WOVEN FABRIC AND
DISPLAY DEVICE USING SAME

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying documents, copies of which are attached to this statement, are made of record on the enclosed Form PTO-1449.

A concise explanation of the relevance of these items is that these references were cited in the corresponding International Application Serial No. PCT/JP2004/012189.

Respectfully submitted,

YOUNG & THOMPSON



Robert J. Patch, Reg. No. 17,355
745 South 23rd Street
Arlington, VA 22202
Telephone (703) 521-2297
Telefax (703) 685-0573
(703) 979-4709

RJP/lk
March 29, 2006



INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)				Attorney Docket No.: 8075-1024	Application No.: 09/562,835		
				Applicant: Kuniyoshi YOKOH et al.			
				Filing Date: December 29, 2005	Group Art Unit:		
U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing date (if appropriate)	
FOREIGN PATENT DOCUMENTS							
Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	JP 4-009688	01/14/1992	JAPAN (with English abstract)				
	JP 5-087934	04/09/1993	JAPAN (with English abstract)				
	JP 2002-350597	12/04/2002	JAPAN (with English abstract)				
	JP 2003-107160	04/09/2003	JAPAN (with English abstract)				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
		TOMOHIKO et al., "Growth of AE(=Ca,Ba)F ₂ and RE(=Pr,Ce)F ₃ crystals by Micro-Pulling-down Method", Vol. 48, pp. 35-36					
EXAMINER:			DATE CONSIDERED				
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

* Abstract provided for the Examiner's convenience